

# ToyMC using gauss distribution

- To confirm the calculation results of the mass limit, we created a toyMC using a Gaussian distribution, performed a fit, and verified the results.
- To sum over all bins & all polarization patterns (total of 6), using the following formula:
- *No charge id 1bin & charge id 2bin(forward-backward)*

$$\sum \left( \frac{(\text{gaussian random number with mean: } \delta\sigma, \text{ sigma: error})}{\text{error}} \right)^2$$

$\delta\sigma = \frac{\sigma_i(\text{BSM}) - \sigma_i(\text{SM})}{\sigma_i(\text{SM})}$ : Deviation of the differential cross – section from the Standard Model for the i – th bin (0 for the Standard Model)

$\text{error} = \frac{\sqrt{S_i + N_i}}{S_i}$ :  $S_i$ : the number of signal event  
 $N_i$ : the number of background event in each bin

- We repeat this process 10,000 times and create two plots: one for the Standard Model in the  $bb$  channel and another for the  $Z'$  model (SSM) in the same channel.
- We perform a chi-squared fit for the Standard Model and a Gaussian fit for the  $Z'$  model.
- To determine the probability of the Standard Model chi-square function at the mean value of the  $Z'$  model Gaussian function and check if it corresponds to a 5-sigma significance.

# ToyMC using gauss distribution

**$Z'$  Model ->SSM**

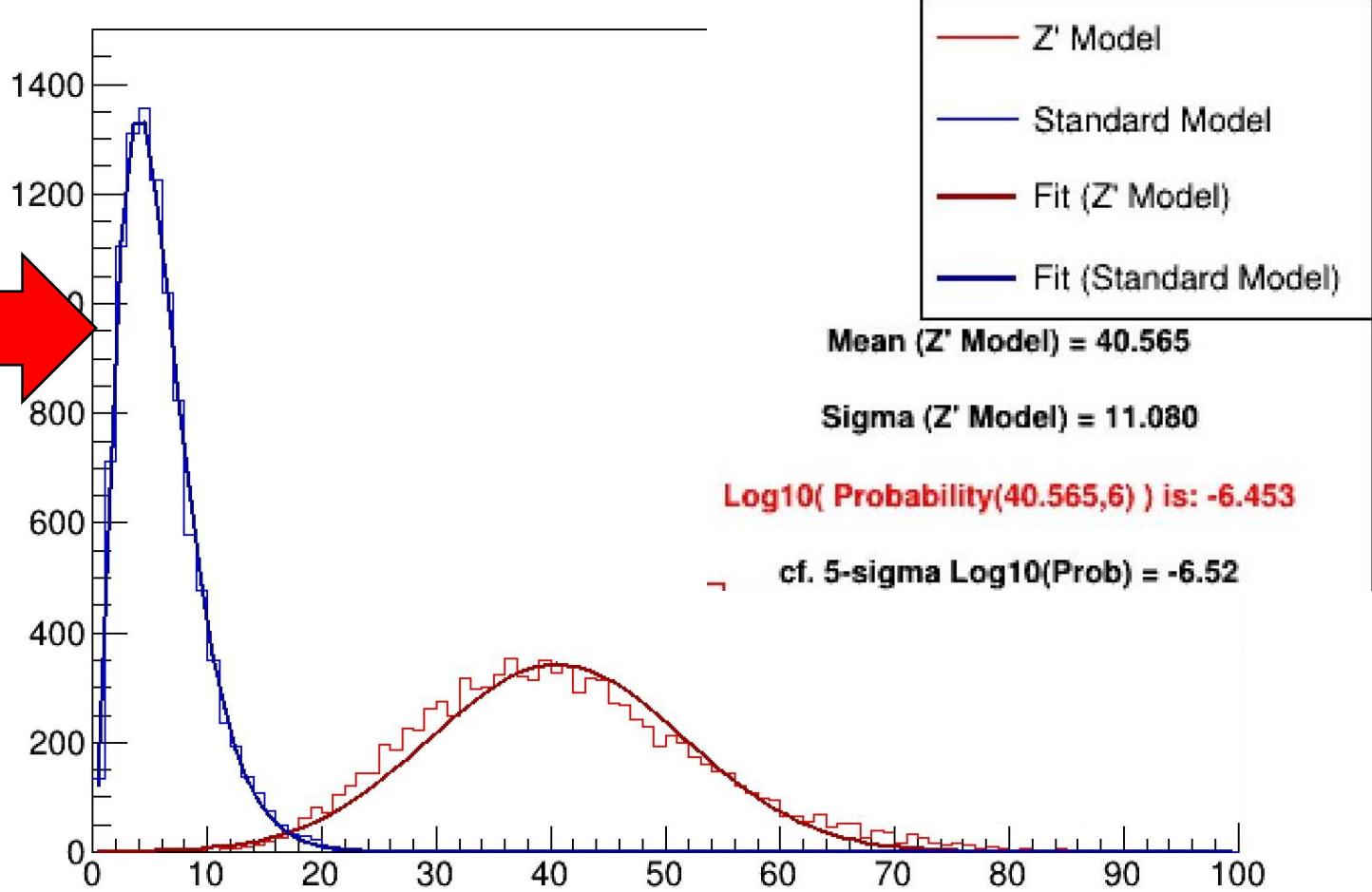
```
proc = bb  
-----  
Ecm =500 [GeV]  
SSM: M(5) = 6.57987 [TeV] M(2) = 9.97448 [TeV]  
-----  
Ecm =500 [GeV]  
ALR: M(5) = 2.68174 ] M(2) = 4.02791 [TeV]  
-----  
Ecm =500 [GeV]  
chi: M(5) = 4.27092 [TeV]  
-----  
Ecm =500 [GeV]  
psi: M(5) = 2.76707 [TeV] M(2) = 4.16277 [TeV]  
-----  
Ecm =500 [GeV]  
eta: M(5) = 2.29504 [TeV] M(2) = 3.43367 [TeV]
```

Mass Limit

5-sigma -> discovery reach

2-sigma -> 95% CL lower limit

Sum of squared random values ( $Z'$  Model)



# Z' の識別性能の評価

- ILCにおける $\cos\theta$ 分布のi番目のビンの精度( $\delta\sigma_i/\sigma_i(SM)$ )  
(今回はforward-backwardの2ビンに分けた)

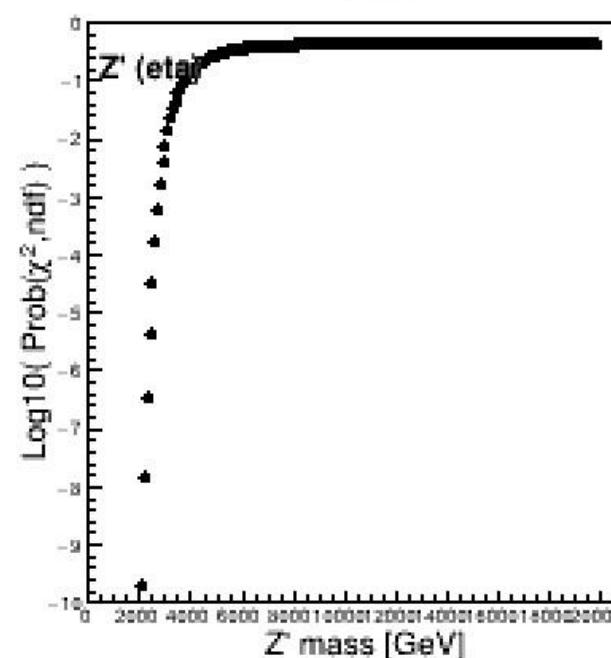
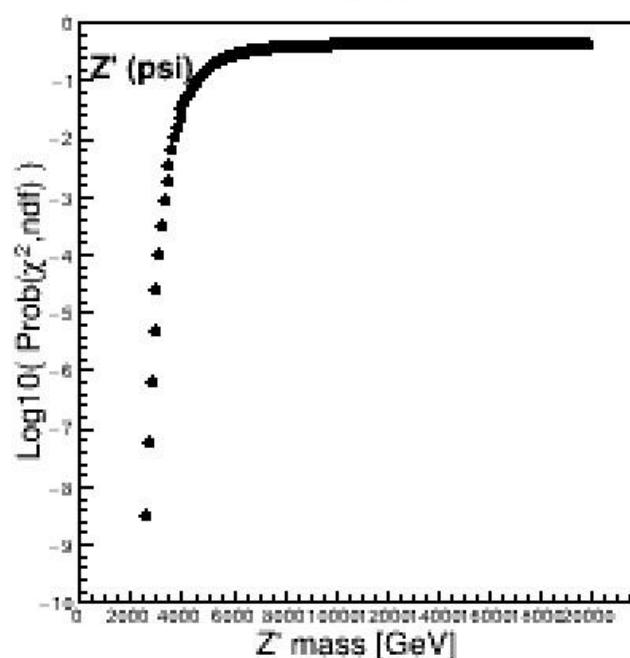
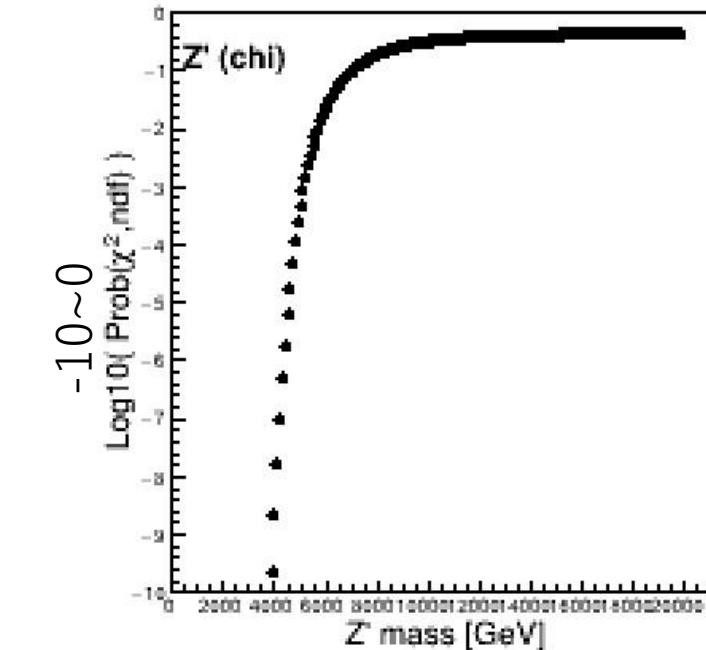
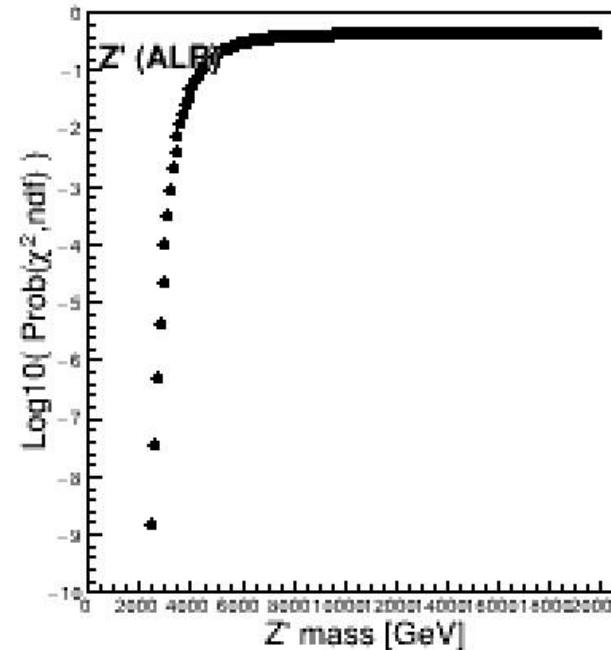
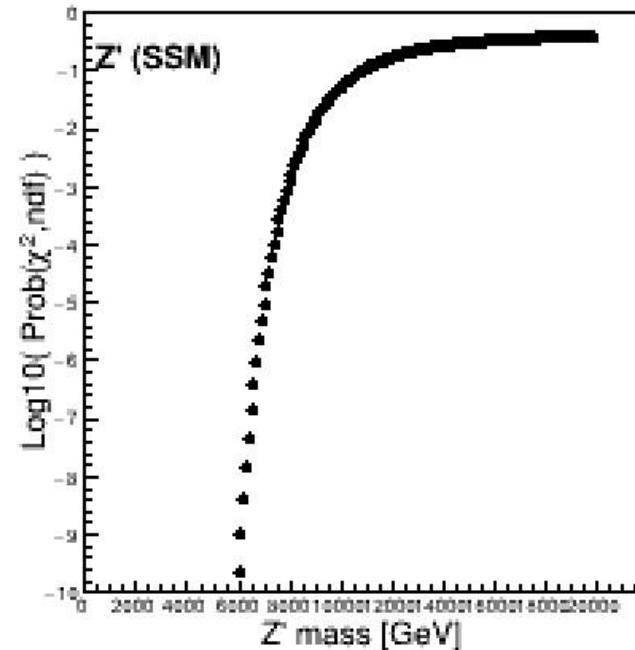
$$\frac{\delta\sigma_i}{\sigma_i(SM)} = \sqrt{\left(\frac{\sqrt{S_i + N_i}}{S_i}\right)^2 + \sigma_{syst}^2}$$

$S_i$ : the number of signal events in each bin.  
 $N_i$ : the number of background events  
In this evaluation, systematic errors of 0.0 for b and 0.0 for c are assumed.

- このi番目のビンに対する標準模型と各モデルによる微分断面積の偏差( $\delta\sigma_i(BSM)/\sigma_i(SM)$ )を計算し、

$$\chi^2(BSM) = \sum_i \left\{ \left( \frac{\delta\sigma_i(BSM)}{\sigma_i(SM)} / \frac{\delta\sigma_i}{\sigma_i(SM)} \right)^2 \right\}$$

から、 $\chi^2$  が得られる



1000~20000

We calculated the overall significance of the  $Z'$  model in the  $bb$  channel by scanning the mass of the  $Z'$  and determined the mass limit.

# Using events

- ILDフルシミュレーション(v02-00-01)を用いた  
クォーク事象@500GeVの生成

- **Signal Events:**

- $e^+e^- \rightarrow q\bar{q}$  ( $Z^*$  true mass  $\geq 450$  GeV)

- **Background Events:**

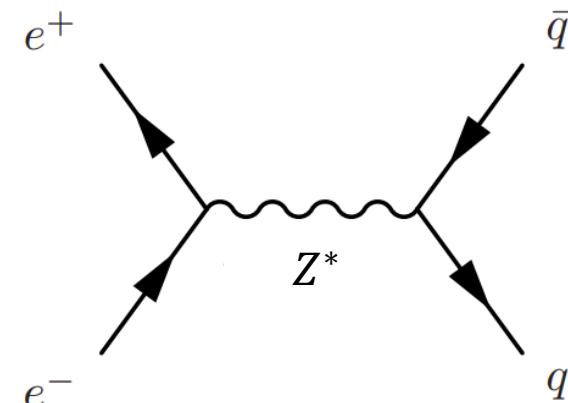
- 2-fermion background

- $e^+e^- \rightarrow q\bar{q}$  ( $Z^*$  true mass  $< 450$  GeV)

- 4-fermion background

- hadronic events (mainly W/Z-derived)

- semileptonic events (mainly W/Z-derived)



- **Polarization**

- $e^-$ :  $\mp 80\%$ ,  $e^+$ :  $\pm 30\%$      $1600 \text{ fb}^{-1}$  each

# Efficiencyの計算( $\cos\theta$ 分布)

- $b\bar{b}$ 、 $cc$ イベントの各ビンのシグナルイベント数 $S_i$ は

$$S_i = \text{cross section} \times \text{luminosity} \times \text{efficiency}$$

である。Efficiencyは $\cos\theta$ に依存し、Charge IDの可否も含めて計算する。

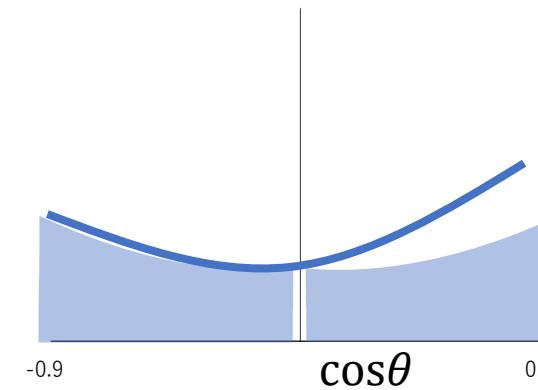
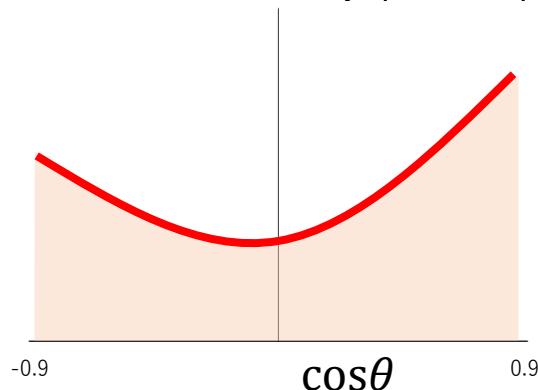
- $b\bar{b}$ の場合( $c\bar{c}$ の場合も同様):

$$\text{efficiency\_angle} = \frac{\# \text{ of } (\text{true } b\bar{b}) \text{ w/ eventcut}}{\# \text{ of } (\text{true } b\bar{b}) \text{ w/o eventcut}} \times \frac{\# \text{ of predicted } b\bar{b}}{\# \text{ of predicted total}} \times \text{Charge ID efficiency}$$

Charge IDされなかったイベントのtotal cross sectionに対するefficiencyとして以下の式を使う。

$$\text{efficiency\_noChargeID} = \frac{\# \text{ of } (\text{true } b\bar{b}) \text{ w/ eventcut}}{\# \text{ of } (\text{true } b\bar{b}) \text{ w/o eventcut}} \times \frac{\# \text{ of predicted } b\bar{b}}{\# \text{ of predicted total}} \times (1 - \text{Charge ID efficiency})$$

Charge IDされなかった場合、各偏極でのtotal cross sectionを用いた



Charge IDされた場合、  
 $\text{costheta} > 0$ と  
 $\text{costheta} < 0$ に  
分けて評価した